THE DATASHEET OF

LMN400B01-7

www.win-source.net 0086-755-83957316

LMN400B01

400mA LOAD SWITCH FEATURING PNP TRANSISTOR AND N-MOSFET WITH GATE PULL-DOWN RESISTOR

Product Summary

Reference	Device Type	R1 (NOM)	R2 (NOM)	R3 (NOM)	Figure
Q1	PNP Transistor	10K	220	—	2
Q2	N-MOSFET	—	—	37K	2

Features

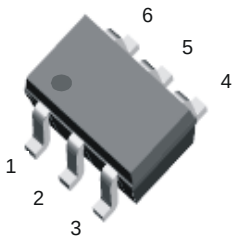
- Voltage Controlled Small Signal Switch
- N-MOSFET with Gate Pull-Down Resistor
- Ideally Suited for Automated Assembly Processes
- **Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)**
- **Halogen and Antimony Free. "Green" Device (Note 3)**

Description

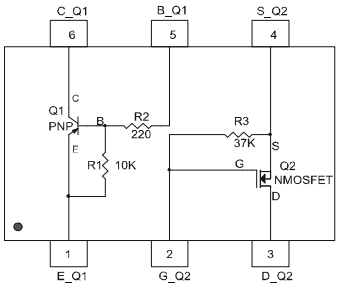
LMN400B01 is best suited for applications where the load needs to be turned on and off using control circuits like micro-controllers, comparators etc. particularly at a point of load. It features a discrete pass transistor with stable $V_{CE(SAT)}$ which does not depend on input voltage and can support continuous maximum current of 400 mA . It also contains a discrete N-MOSFET with gate pull-down resistor that can be used as control. The component devices can be used as a part of a circuit or as a stand alone discrete device.

Mechanical Data

- Case: SOT26
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture sensitivity: Level 1 per J-STD-020C
- Terminal Connections: See Diagram
- Terminals: Finish - Matte Tin annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208 e3
- Weight: 0.016 grams (approximate)



Top View



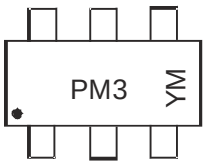
Top View
Internal Schematic

Ordering Information (Note 4)

Part Number	Case	Packaging
LMN400B01-7	SOT26	3000/Tape & Reel

Notes:
1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
2. See http://www.diodes.com for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
4. For packaging details, go to our website at http://www.diodes.com.

Marking Information



PM3 = Product Type Marking Code,
YM = Date Code Marking
Y = Year, e.g., Z = 2012
M = Month, e.g., 9 = September

Date Code Key

Year	2006	2007	…..	2012	2013	2014	2015	2016	2017
Code	T	U	…..	Z	A	B	C	D	E

Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	O	N	D

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Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 5)	P_D	300	mW
Power Derating Factor above +100°C	P_{DER}	2.4	mW/°C
Output Current	I_{OUT}	400	mA

Thermal Characteristics

Characteristic	Symbol	Value	Unit
Operating and Storage Temperature Range	T_J, T_{STG}	-55 to +150	°C
Thermal Resistance, Junction to Ambient Air (Note 5)	$R_{\theta JA}$	417	°C/W

Maximum Ratings: Pre-Biased PNP Transistor (Q1) (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Supply Voltage	V_{CC}	-50	V
Input Voltage	V_{IN}	-6 to +5	V
Output Current	I_C	-400	mA

Maximum Ratings: ESD Protected N-Channel MOSFET (Q2) (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Drain-Source Voltage		V_{DSS}	60	V
Drain Gate Voltage (R_{GS} ≤1MΩ)		V_{DGR}	60	V
Gate-Source Voltage	Continuous	V_{GSS}	+/-20	V
	Pulsed (tp < 50µS)		+/-40	
Drain Current (Note 5)	Continuous (V_{GS} = 10V)	I_D	115	mA
	Pulsed (tp <10µS, Duty Cycle <1%)		800	
Continuous Source Current		I_S	115	mA

Note: 5. Device mounted on FR-4 PCB, 1 inch x 0.85 inch x 0.062 inch; pad layout as shown on Diodes Inc. suggested pad layout document AP02001, which can be found on our website at http://www.diodes.com/datasheets/ap02001.pdf.

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Electrical Characteristics: Pre-Biased PNP Transistor (Q1) (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 6)						
Collector-Base Cut Off Current	I_{CBO}	—	—	-500	nA	V_{CB} = -50V, I_E = 0
Collector-Emitter Cut Off Current	I_{CEO}	—	—	-1	µA	V_{CE} = -50V, I_B = 0
Collector-Base Breakdown Voltage	$V_{(BR)CBO}$	-50	—	—	V	I_C = -10µA, I_E = 0
Collector-Emitter Breakdown Voltage	$V_{(BR)CEO}$	-50	—	—	V	I_C = -2mA, I_B = 0
Input Off Voltage	$V_{I(OFF)}$	-0.3	—	—	V	V_{CE} = -5V, I_C = -100µA
Ouput Current	$I_{O(OFF)}$	—	—	-1	µA	V_{CC} = -50V, V_I = 0V
ON CHARACTERISTICS (Note 6)						
Collector-Emitter Saturation Voltage	$V_{CE(SAT)}$	—	-0.06	-0.15	V	I_C = -10mA, I_B = -0.3mA
		—	-0.18	-0.30	V	I_C = -300mA, I_B= -30mA
		—	-0.28	-0.60	V	I_C = -500mA, I_B = -50mA
DC Current Gain	h_{FE}	55	220	—	—	V_{CE} = -5V, I_C = -50mA
		55	260	—	—	V_{CE} = -5V, I_C = - 100mA
		55	265	—	—	V_{CE} = -5V, I_C = -200 mA
		55	225	—	—	V_{CE} = -5V, I_C = -400mA
Input On Voltage	$V_{I(ON)}$	-3.0	-1.5	—	V_{DC}	V_O = -0.3V, II$_C$ = -2mA
Input Current	I_i	—	-18	-45	mA	V_I = -5V
Base-Emitter Turn-on Voltage	$V_{BE(ON)}$	—	-1.2	-1.6	V	V_{CE} = -5V, I_C = -400mA
Base-Emitter Saturation Voltage	$V_{BE(SAT)}$	—	-1.9	-2.5	V	I_C = -50mA, I_B = -5mA
		—	-5.25	-6.00		I_C = -400mA, I_B = -20mA
Input Resistor (Base), +/- 30%	R2	0.154	0.220	0.286	KΩ	—
Pull-up Resistor (Base to V_{CC} supply), +/- 30%	R1	7	10	13	KΩ	—
Resistor Ratio (Input Resistor/Pullup resistor)	R1/R2	36	45	55	—	—
SMALL SIGNAL CHARACTERISTICS						
Gain Bandwidth Product	f_T	—	200	—	MHz	V_{CE} = -10V, I_E = -5mA, f = 100MHz

* Pulse Test: Pulse width, tp <300µs, Duty Cycle, d ≤ 0.02
Note: 6. Short duration pulse test used to minimize self-heating effect.

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Electrical Characteristics:
ESD Protected N-Channel MOSFET (Q2) (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 6)						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	60	—	—	V	V_{GS} = 0V, I_D = 10µA
Zero Gate Voltage Drain Current	I_{DSS}	—	—	1	µA	V_{GS} =0V, V_{DS} = 60V
Gate-Body Leakage Current, Forward	I_{GSSF}	—	—	0.95	mA	V_{GS} = 20V, V_{DS} = 0V
Gate-Body Leakage Current, Reverse	I_{GSSR}	—	—	-0.95	mA	V_{GS} = -20V, V_{DS} = 0V
ON CHARACTERISTICS (Note 6)						
Gate Source Threshold Voltage	$V_{GS(th)}$	1	1.6	2.5	V	V_{DS} = V_{GS}, I_D = 0.25mA
Static Drain-Source On-State Voltage	$V_{DS(on)}$	—	0.09	1.5	V	V_{GS} = 5V, I_D = 50mA
		—	0.6	3.75		V_{GS} = 10V, I_D = 500mA
On-State Drain Current	$I_{D(on)}$	500	—	—	mA	V_{GS} = 10V, $V_{DS} \geq 2*V_{DS(ON)}$
Static Drain-Source On Resistance	$R_{DS(on)}$	—	1.6	3	Ω	V_{GS} = 5V, I_D = 50mA
		—	1.2	2		V_{GS} = 10V, I_D = 500mA
Forward Transconductance	g_{FS}	80	260	—	mS	$V_{DS} \geq 2*V_{DS(ON)}$, I_D = 200 mA
Gate Pull-Down Resistor, +/- 35%	R3	—	37	—	kΩ	—
DYNAMIC CHARACTERISTICS						
Input Capacitance	C_{iss}	—	—	50	pF	V_{DS} = -25V, V_{GS} = 0V, f = 1MHz
Output Capacitance	C_{oss}	—	—	25	pF	
Reverse Transfer Capacitance	C_{rss}	—	—	5	pF	
SWITCHING CHARACTERISTICS*						
Turn-On Delay Time	$td_{(on)}$	—	—	20	ns	V_{DD} = 30V, V_{GS} =10V, I_D = 200mA, R_G = 25Ω, R_L = 150Ω
Turn-Off Delay Time	$td_{(off)}$	—	—	40	ns	
SOURCE-DRAIN (BODY) DIODE CHARACTERISTICS AND MAXIMUM RATINGS						
Drain-Source Diode Forward On-Voltage	V_{SD}	—	0.88	1.5	V	V_{GS} = 0V, I_S = 300 mA*
Maximum Continuous Drain-Source Diode Forward Current (Reverse Drain Current)	I_S	—	—	300	mA	—
aximum Pulsed Drain-Source Diode Forward Current	I_{SM}	—	—	800	mA	—

* Pulse Test: Pulse width, tp <300µs, Duty Cycle, d ≤0.02

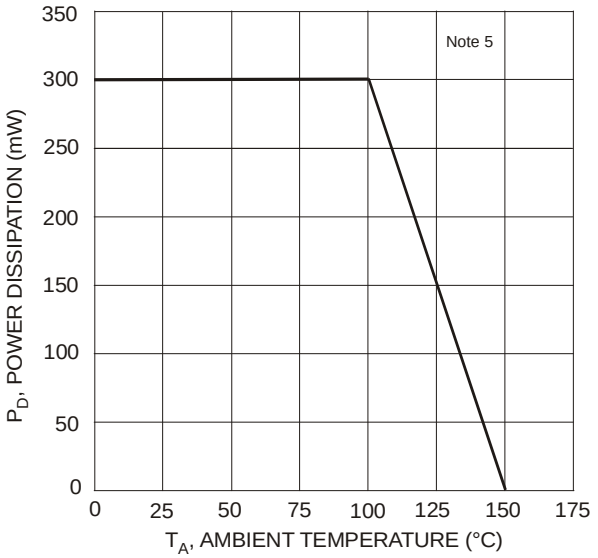

Fig. 3 Max Power Dissipation vs. Ambient Temperature

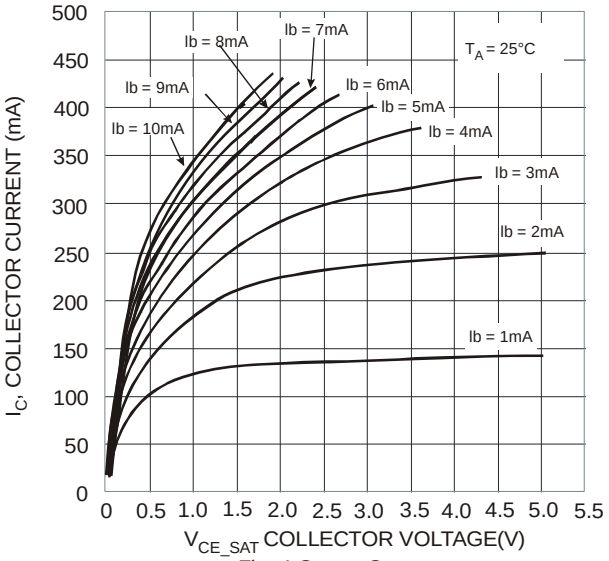

Fig. 4 Output Current vs.
Voltage Drop (Pass Element PNP)

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Pre-Biased PNP Transistor Characteristics

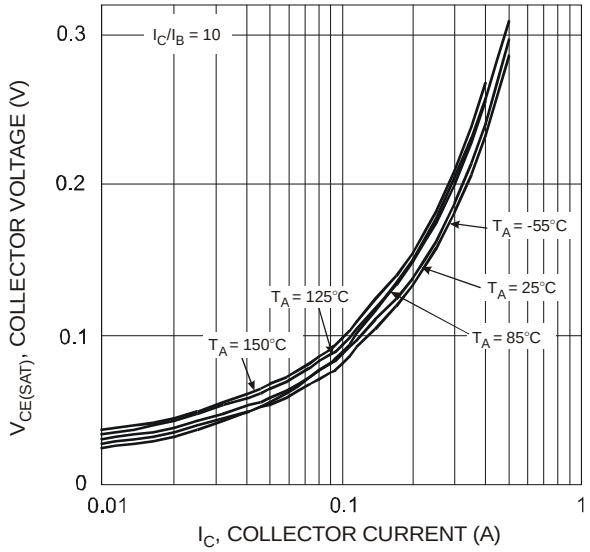

Fig. 5 $V_{CE(SAT)}$ vs. I_C

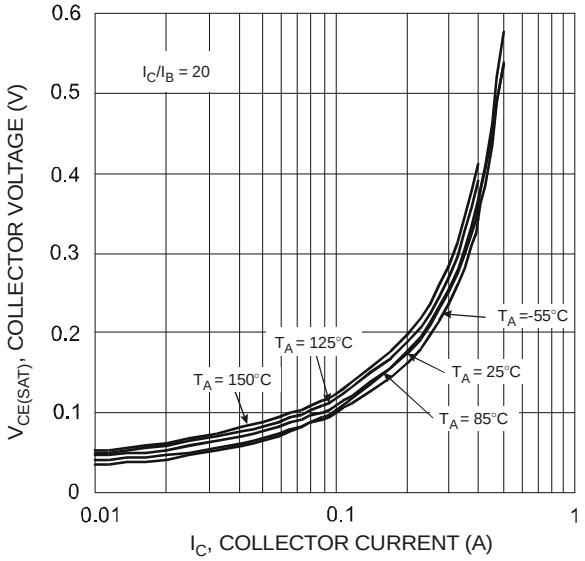

Fig. 6 $V_{CE(SAT)}$ vs. I_C

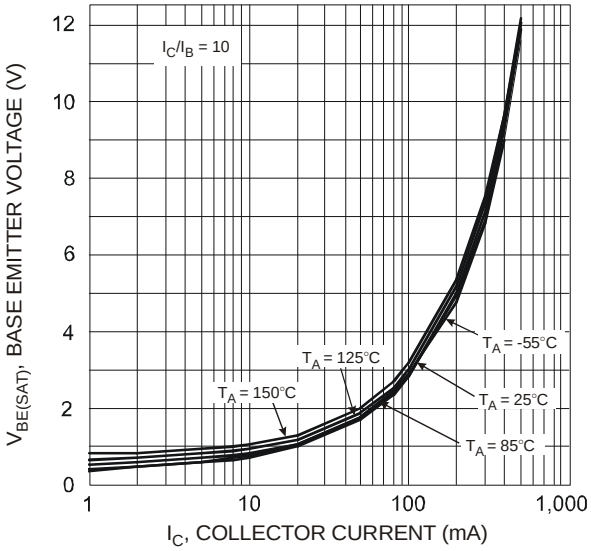

Fig. 7 $V_{BE(SAT)}$ vs. I_C

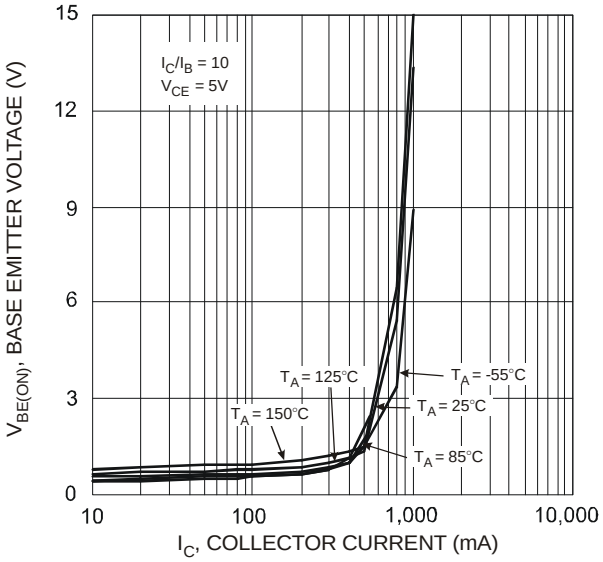

Fig. 8 $V_{BE(ON)}$ vs. I_C

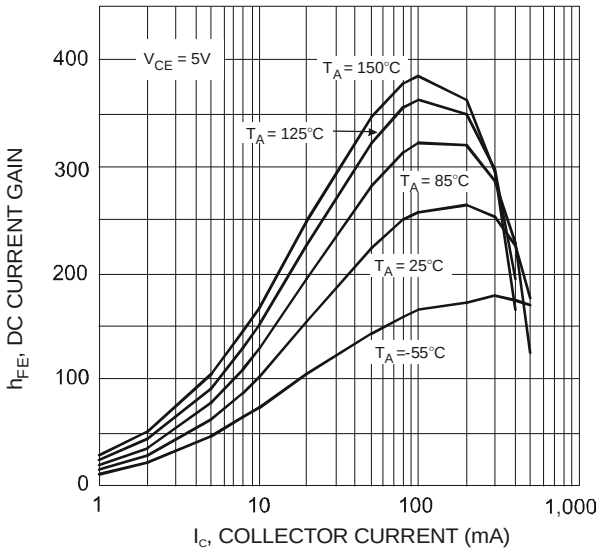

Fig. 9 h_{FE} vs. I_C

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Typical N-Channel MOSFET (Q2) Characteristics

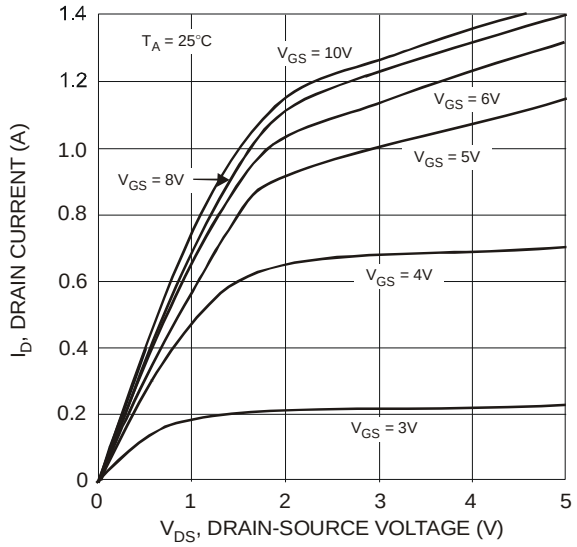

Fig. 10 Output Characteristics

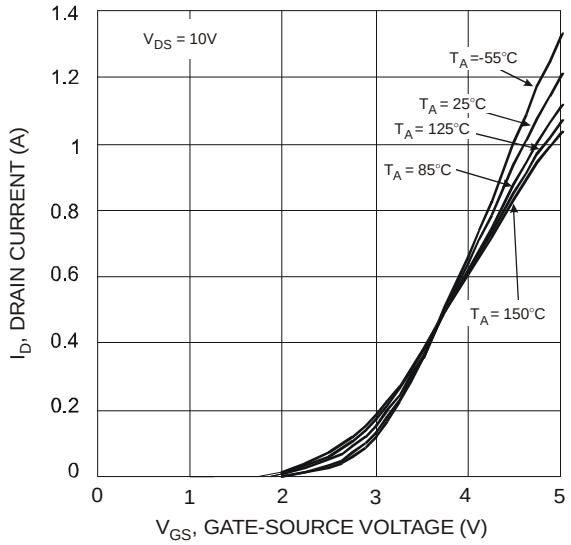

Fig. 11 Transfer Characteristics

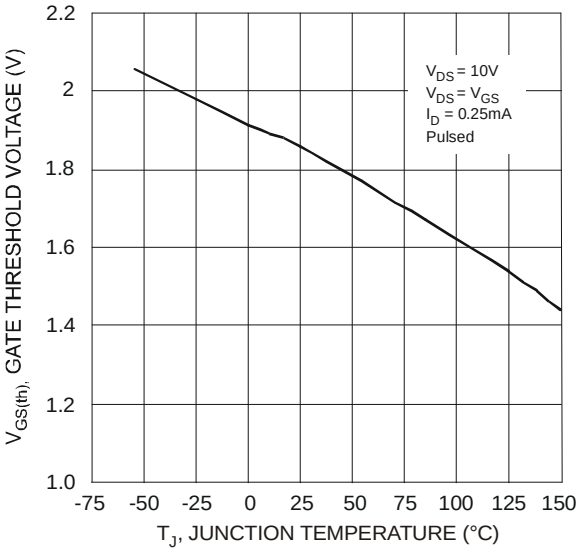

Fig. 12 Gate Threshold Voltage vs. Junction Temperature

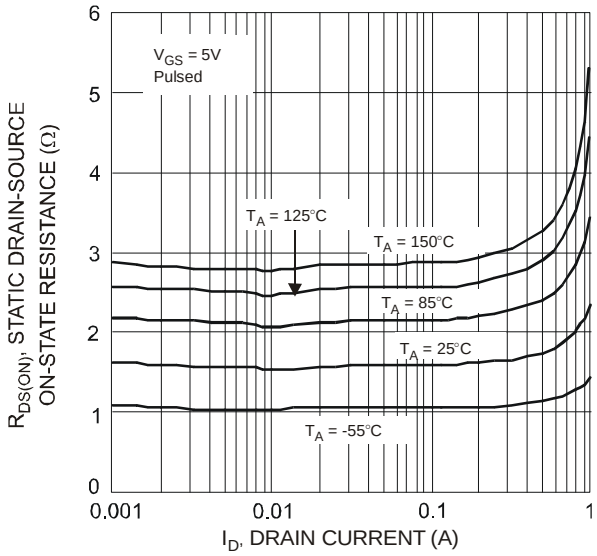

Fig. 13 Static Drain-Source On-Resistance vs. Drain Current

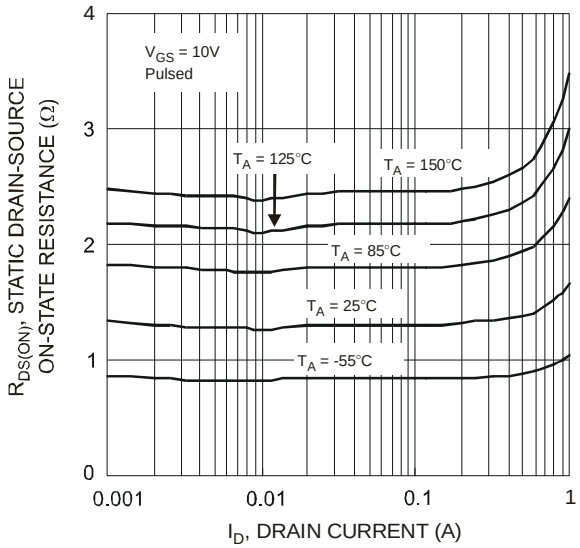

Fig. 14 Static Drain-Source On-Resistance vs. Drain Current

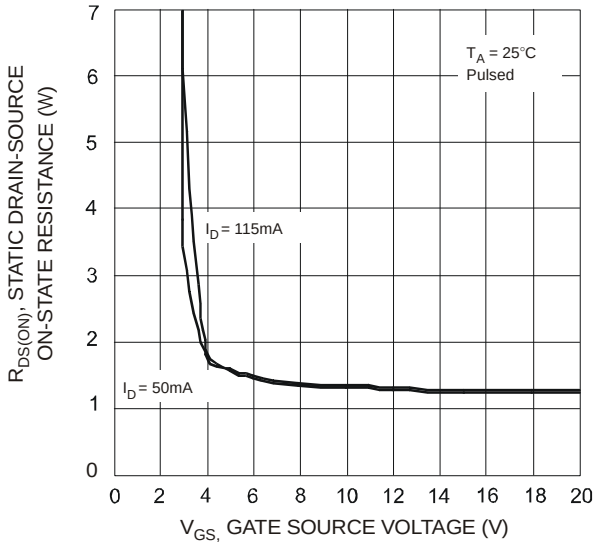

Fig. 15 Static Drain-Source On-Resistance vs. Gate-Source Voltage

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Typical N-Channel MOSFET (Q2) Characteristics (cont.)

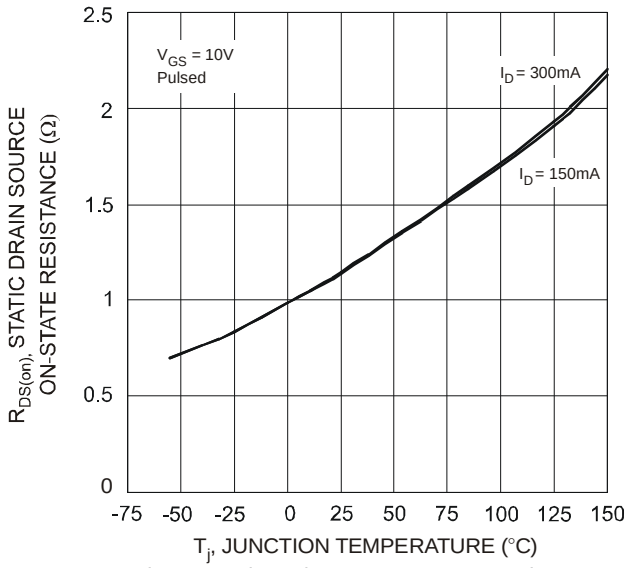

Fig. 16 Static Drain-Source On-State Resistance vs. Junction Temperature

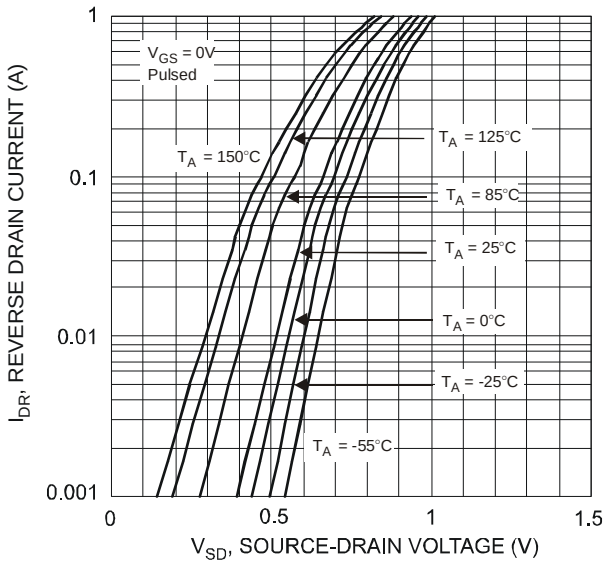

Fig. 17 Reverse Drain Current vs. Source-Drain Voltage

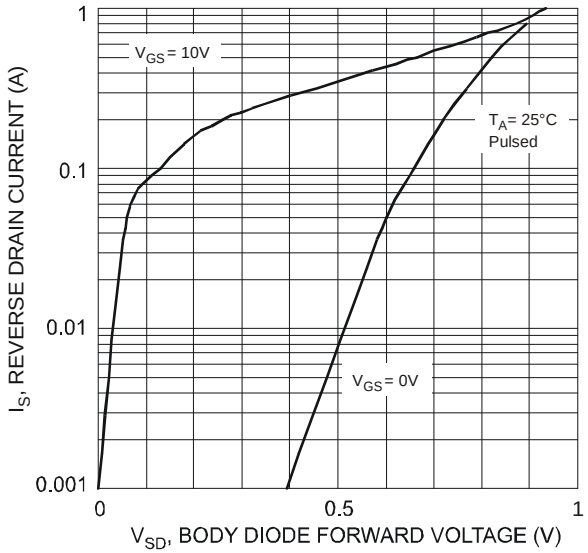

Fig. 18 Reverse Drain Current vs. Source-Drain Voltage

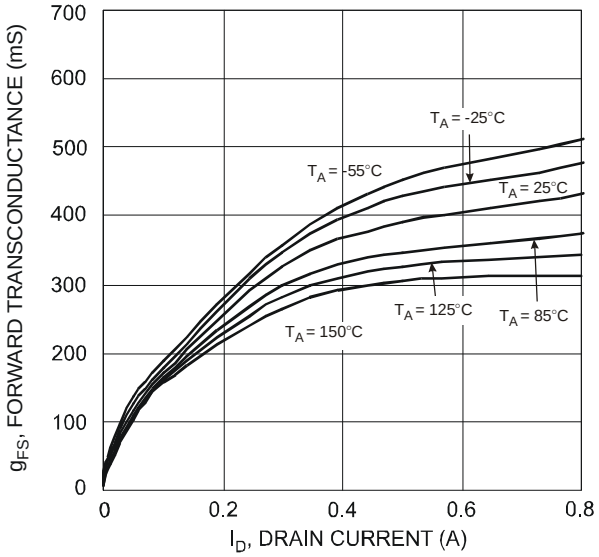

Fig. 19 Forward Transconductance vs. Drain Current ($V_{DS} > I_D * R_{DS(ON)}$)

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Application Details

PNP Transistor and ESD Protected N-MOSFET integrated as one in LMN400E01 can be used as a discrete entity for general applications or as an integrated circuit to function as a Load Switch. When it is used as the latter as shown in Figure 20, various input voltage sources can be used as long as it does not exceed the maximum ratings of the device. These devices are designed to deliver continuous output load current up to a maximum of 400mA. The MOSFET Switch draws no current, hence the loading of the control circuitry is prevented. Care must be taken for higher levels of dissipation while designing for higher load conditions. These devices provide high power and also consume less space. The product mainly helps in optimizing power usage, thereby conserving battery life in a controlled load system like portable battery powered applications. (Please see Figure 21 for one example of a typical application circuit used in conjunction with a voltage regulator as a part of power management system).

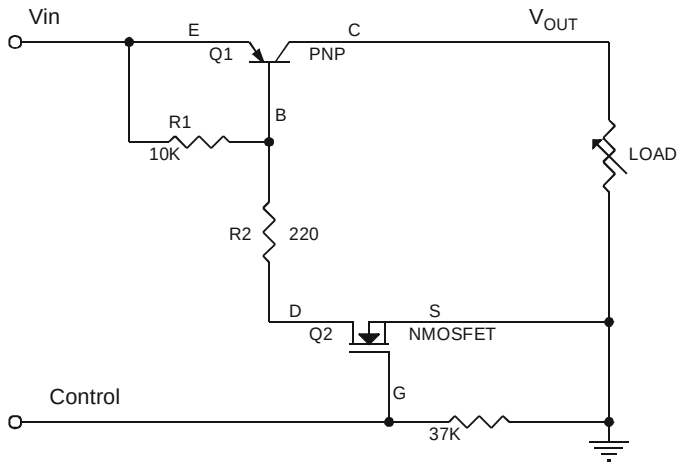


Figure 20 Circuit Diagram

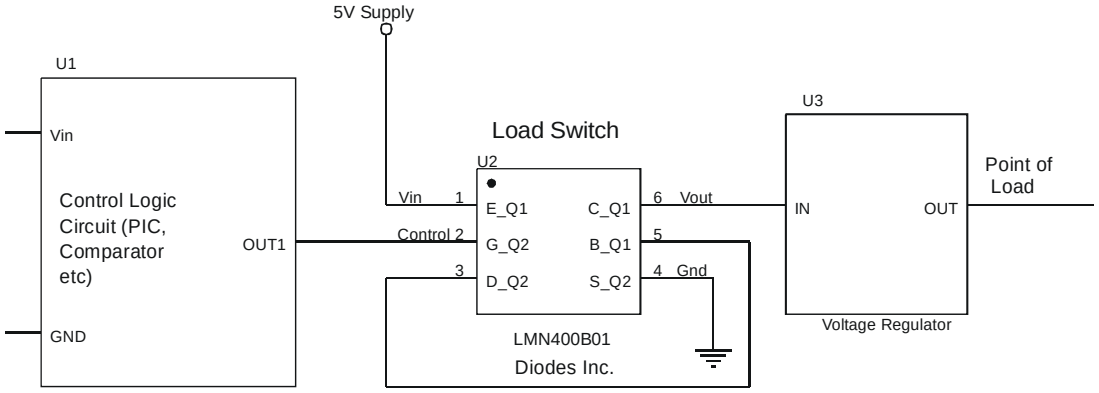
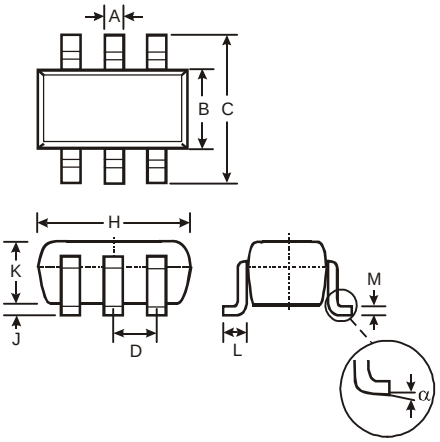


Figure 21 Typical Application Circuirt

Package Outline Dimensions



SOT26			
Dim	**Min**	**Max**	**Typ**
A	0.35	0.50	0.38
B	1.50	1.70	1.60
C	2.70	3.00	2.80
D	—	—	0.95
H	2.90	3.10	3.00
J	0.013	0.10	0.05
K	1.00	1.30	1.10
L	0.35	0.55	0.40
M	0.10	0.20	0.15
α	0°	8°	—
All Dimensions in mm			

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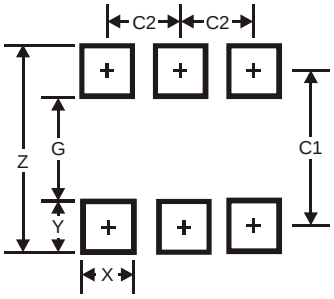
Suggested Pad Layout



Dimensions	Value (in mm)
Z	3.20
G	1.60
X	0.55
Y	0.80
C1	2.40
C2	0.95

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2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.

B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

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